

# SSC8LA12GT4

## N-Channel Enhancement Mode MOSFET

#### > Features

V <sub>DS</sub>	V <sub>GS</sub>	R <sub>DS(ON)</sub>	ID
100V	+20V	3.7mΩ@10V	150A
100 v	<u> </u>	4.9mΩ@4V5	1304

#### > Description

This device is N-Channel enhancement MOSFET. Uses SGT technology and design to provide excellent RDSON with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit.

100% UIS + ΔVDS + Rg Tested!

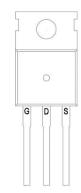
### > Applications

- Motor Drive Control
- Portable Devices
- DCDC Conversion
- Power Supplies
- Synchronous Rectification

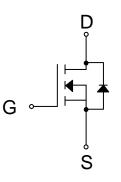
#### > Ordering Information

Device	Package	Shipping	
SSC8LA12GT4	TO-220-3L	50/Tube	

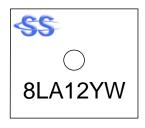
# Pin Configuration



TO-220-3L (Top View)



Pin Configuration



# <u>Marking</u> (YW: Internal Traceability Code)





Symbol	Parameter	Ratings	Unit		
V <sub>DSS</sub>	Drain-to-Source Voltage		100	V	
V <sub>GSS</sub>	Gate-to-Source Volta	ge	±20	V	
	Continuous Drain Current d	Tc <b>=25</b> ℃	150		
ID	T <sub>c</sub> =100°	Tc=100℃	69	A	
	Orationers Durin Oranata	T <sub>A</sub> =25℃	26		
IDSM	Continuous Drain Current <sup>a</sup>	T <sub>A</sub> =70℃	19	A	
IDM	Pulsed Drain Current <sup>b</sup>		450	A	
5		Tc=25℃	96		
PD	Power Dissipation <sup>c</sup>	Tc=25℃ Tc=100℃	38	W	
5	Duran Dissistantian A	T <sub>A</sub> =25℃	4.2		
Pdsm	Power Dissipation <sup>a</sup>	T <b></b> , <b>=70</b> ℃	2.7	W	
las	Avalanche Current <sup>b</sup> L=0.5mH Single Pulse		45	А	
Eas	Avalanche Energy <sup>b</sup> L=0.5mH Single Pulse		506	mJ	
TJ	Operation junction temperature		-55~150	°C	
Tstg	Storage temperature range		-55~150	°C	

#### > Absolute Maximum Ratings ( $T_A=25^{\circ}$ unless otherwise noted)

#### ➤ Thermal Resistance Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
R <sub>0JA</sub>	Junction-to-Ambient Thermal Resistance <sup>a</sup>	30	°C/W
R <sub>θJC</sub>	Junction-to-Case Thermal Resistance	1.0	C/ <b>V</b>

Note:

- a. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper, in a still air environment with T<sub>A</sub>=25 °C.The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.



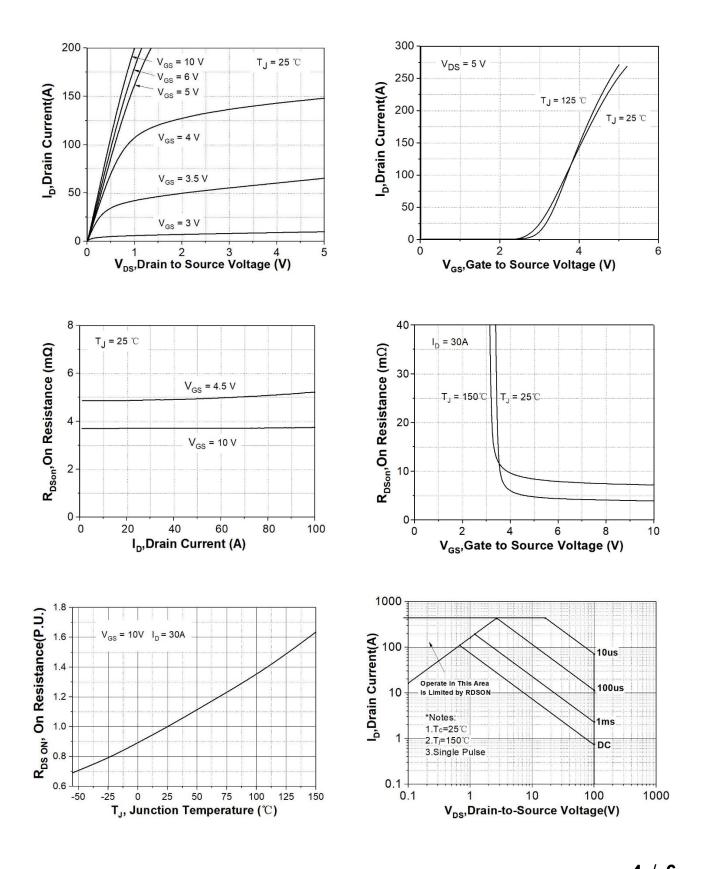


# $\succ$ Electrical Characteristics (T<sub>A</sub>=25 °C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA	100			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250 uA$	1.4	2	2.5	V
Drain Source On Desistance	Dear	V <sub>GS</sub> = 10V, I <sub>D</sub> = 30A		3.7	5	
Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 20A		4.9	7.5	mΩ
Zero Gate Voltage Drain Current	loss	V <sub>DS</sub> = 80V, V <sub>GS</sub> = 0V			1	μA
Gate-Source Leak Current	lgss	$V_{GS}$ = ±20V, $V_{DS}$ = 0V			±100	nA
Transconductance	G <sub>FS</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 20A		60		s
Forward Voltage	Vsd	V <sub>GS</sub> = 0V, I <sub>S</sub> = 20A		0.8	1.3	V
Gate Resistance	R <sub>G</sub>	V <sub>DS</sub> = 0V, f = 1MHz		2.7		Ω
Input Capacitance	Ciss	$\lambda = 50 \lambda \lambda = 0 \lambda$		4560		
Output Capacitance	Coss	$V_{DS} = 50V, V_{GS} = 0V,$ f = 1MHz		674		pF
Reverse Transfer Capacitance	Crss			31		
Total Gate Charge	Q <sub>G</sub>			64		
Gate to Source Charge	Q <sub>GS</sub>	$V_{\rm GS} = 10V, V_{\rm DS} = 50V,$		15		nC
Gate to Drain Charge	$Q_{GD}$	I <sub>D</sub> = 20A		11		
Turn-on Delay Time	T <sub>D(ON)</sub>			22		
Rise Time	Tr	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 50V,		27		
Turn-off Delay Time	T <sub>D(OFF)</sub>	R <sub>L</sub> = 2.5Ω, R <sub>G</sub> = 3Ω		66		ns
Fall Time	T <sub>f</sub>			73		
Diode Recovery Time	Trr	I⊧=20A, di/dt=100A/us		50		ns
Diode Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> =20A, di/dt=100A/us		110		nC



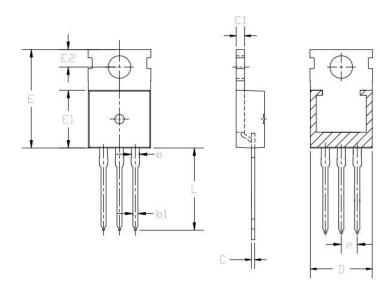
# > Typical Performance Characteristics (T<sub>A</sub>=25 $^{\circ}$ C unless otherwise noted)



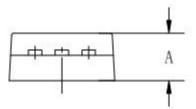


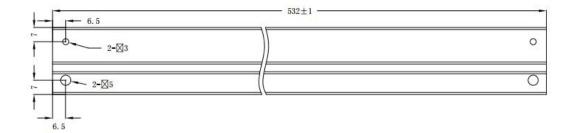
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# > Package Information

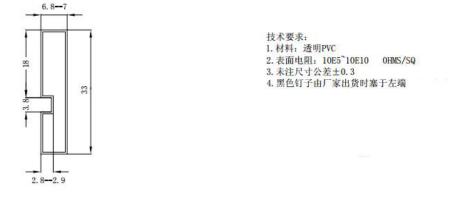


aumou	MILLIMETER			
SYMBOL	MIN	NOM	MAX	
A	4.40		4.60	
b	1.20	100000	1.36	
b1	0.70	1222	0.90	
C	0.48	-	0.53	
C1	1.28	1000	1.32	
D	9.80	10.00	10.20	
E	15.20	15,45	15,75	
E1	9.00	9.20	9.40	
E2	2.6.0	10.773	2.90	
e		2.54	1000	
L	13.00		13,40	





 $T=0.5 \pm 0.1$ 





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